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Application No. <u>09945512</u>	Prepared by <u>MRUSIA</u>	Tracking Number <u>05974755</u>	
Examiner-GAU <u>BROTH-2812</u>	Date <u>10-04-04</u>	Week Date <u>07-05-04</u>	
	No. of queries <u>1</u>	<u>IPW</u>	

JACKET

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|----------------------|------------------------|--------------------|-------------------|
| a. Serial No. | f. Foreign Priority | k. Print Claim(s) | <u>p</u> PTO-1449 |
| b. Applicant(s) | g. Disclaimer | l. Print Fig. | q. PTOL-85b |
| c. Continuing Data | h. Microfiche Appendix | m. Searched Column | r. Abstract |
| d. PCT | i. Title | n. PTO-270/328 | s. Sheets/Figs |
| e. Domestic Priority | j. Claims Allowed | o. PTO-892 | t. Other |

SPECIFICATION

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- g. Brief Description
- h. Sequence Listing
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MESSAGE

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RESPONSE

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AUG 30 2004

PTO/2004/1001
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Substitute for form 1449A-PTO

**INFORMATION DISCLOSURE
 STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Complete if Known

Application Number	09/945,512
Filing Date	August 30, 2001
First Named Inventor	Forbes, Leonard
Group Art Unit	2812
Examiner Name	Booth, Richard

Sheet 1 of 1

Attorney Docket No: 1303.027US1

US PATENT DOCUMENTS

Examiner Initial *	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	Filing Date if Appropriate
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DATE CONSIDERED

Substitute Disclosure Statement Form (PTO-1449)

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
(Use as many sheets as necessary)



Priority Data	
Application Number	09/945512
Filing Date	August 30, 2001
First Named Inventor	Forbes, Leonard
Group Art Unit	2812
Examiner Name	Booth, Richard
Attorney Docket No. 1303.027US1	

Sheet 1 of 1

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Examiner Initials	Foreign Document No.	Publication Date	Name of Patent or Applicant of cited Document	Class	Subclass	T*
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OTHER DOCUMENTS - NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T*
		SHI, Y., "Tunneling Leakage Current in Ultrathin (<4 nm) Nitride/Oxide Stack Dielectrics", IEEE Electron Device Letters, 19(10), (1998), pp. 388-390	
		ZHANG, "Atomic Layer Deposition of High Dielectric Constant Nanolaminates", Journal of The Electrochemical Society, 148(4), (2001), F63-F69	

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